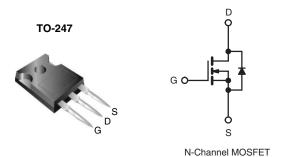


Vishay Siliconix

## **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	600			
$R_{DS(on)}\left(\Omega\right)$	V <sub>GS</sub> = 10 V	0.60		
Q <sub>g</sub> (Max.) (nC)	84			
Q <sub>gs</sub> (nC)	18			
Q <sub>gd</sub> (nC)	36			
Configuration	Single			



### **FEATURES**

- Ultra Low Gate Charge
- · Reduced Gate Drive Requirement
- Enhanced 30 V V<sub>GS</sub> Rating
- Reduced C<sub>iss</sub>, C<sub>oss</sub>, C<sub>rss</sub>
- · Isolated Central Mounting Hole
- Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- Lead (Pb)-free Available

### **DESCRIPTION**

This new series of low charge Power MOSFETs achieve significantly lower gate charge over conventional MOSFETs. Utilizing advanced Power MOSFET technology the device improvements allow for reduced gate drive requirements, faster switching speeds and increased total system savings. These device improvements combined with the proven ruggedness and reliability of Power MOSFETs offer the designer a new standard in power transistors for switching applications.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because its isolated mounting hole.

ORDERING INFORMATION	
Package	TO-247
Load (Dh) from	IRFPC50LCPbF
Lead (Pb)-free	SiHFPC50LC-E3
SnPb	IRFPC50LC
Oill b	SiHFPC50LC

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	600	V	
Gate-Source Voltage			$V_{GS}$	± 30		
Continuous Drain Current	V <sub>GS</sub> at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	I <sub>D</sub>	11		
	VGS at 10 V			7.3	Α	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	44		
Linear Derating Factor				1.5	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	920	mJ	
Repetitive Avalanche Currenta			I <sub>AR</sub>	11	Α	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	19	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		$P_{D}$	190	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	3.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 1	10 s		300 <sup>d</sup>	7	
Mounting Torque	6 22 or N	6-32 or M3 screw		10	lbf ⋅ in	
	0-32 OF IVIS SCIEW			1.1	N⋅m	

### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD} = 25 \text{ V}$ , starting  $T_J = 25 \,^{\circ}\text{C}$ ,  $L = 13 \,^{\circ}\text{MH}$ ,  $R_G = 25 \,^{\circ}\Omega$ ,  $I_{AS} = 11 \,^{\circ}\text{A}$  (see fig. 12).
- c.  $I_{SD} \le 11$  A,  $dI/dt \le 100$  A/ $\mu$ s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFPC50LC, SiHFPC50LC

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THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40	
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24	-	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.65	

PARAMETER	SYMBOL	TEST	TEST CONDITIONS			MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0	600	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	to 25 °C, I <sub>D</sub> = 1 mA	-	0.59	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V$	$V_{DS} = V_{GS}, I_D = 250 \mu A$		-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ± 20 V		-	-	± 100	nA
7 0 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1		V <sub>DS</sub> = 60	V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V		-	25	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 480 V, V	/ <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	μΑ
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 6.6 A <sup>b</sup>	-	-	0.60	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 100 V, I <sub>D</sub> = 6.6 A <sup>b</sup>		7.0	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V}, \\ V_{DS} = 25 \text{ V}, \\ f = 1.0 \text{ MHz, see fig. 5}$		-	2300	-	pF
Output Capacitance	C <sub>oss</sub>			-	270	-	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	28	-	
Total Gate Charge	Qg		$V_{GS} = 10 \text{ V}$ $I_D = 11 \text{ A}, V_{DS} = 360 \text{ V}, \\ \text{see fig. 6 and } 13^b$	-	-	84	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V		-	-	18	
Gate-Drain Charge	Q <sub>gd</sub>			-	-	36	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD}$ = 300 V, $I_D$ = 11 A , $R_G$ = 6.2 $\Omega$ , $R_D$ = 30 $\Omega$ , see fig. 10 <sup>b</sup>		-	17	-	ns
Rise Time	t <sub>r</sub>			-	32	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	41	-	
Fall Time	t <sub>f</sub>			-	26	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	-11
Internal Source Inductance	L <sub>S</sub>			-	13	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbo	MOSFET symbol showing the		-	11	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		ı	-	44	
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 11 A, V <sub>GS</sub> = 0 V <sup>b</sup>		ı	-	1.4	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 11 A, dl/dt = 100 A/μs <sup>b</sup>		ı	590	890	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	4.5	6.8	μС
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub>				L <sub>D</sub> )	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300  $\mu s$ ; duty cycle  $\leq$  2 %.



### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

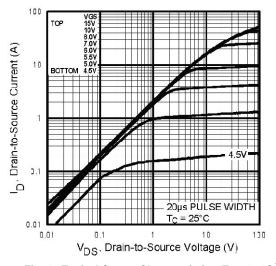


Fig. 1 - Typical Output Characteristics,  $T_C$  = 25 °C

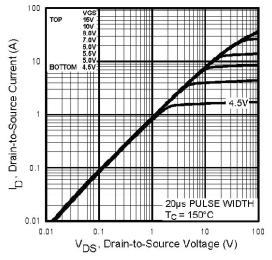


Fig. 2 - Typical Output Characteristics,  $T_C$  = 150 °C

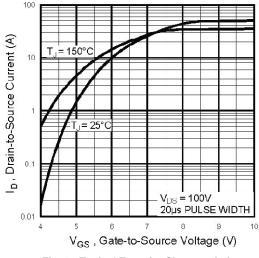


Fig. 3 - Typical Transfer Characteristics

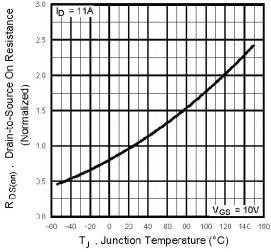


Fig. 4 - Normalized On-Resistance vs. Temperature

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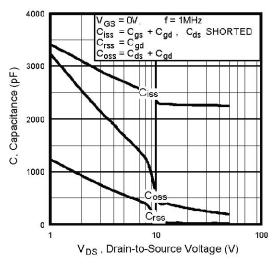


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

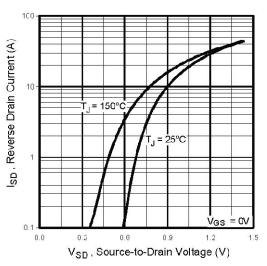


Fig. 7 - Typical Source-Drain Diode Forward Voltage

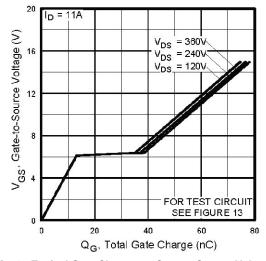


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

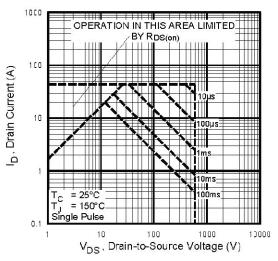


Fig. 8 - Maximum Safe Operating Area



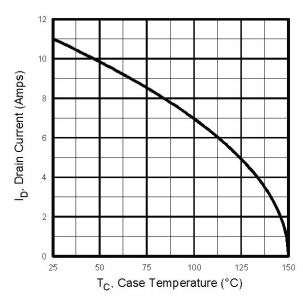


Fig. 9 - Maximum Drain Current vs. Case Temperature

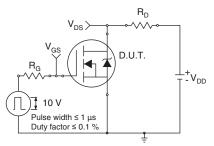


Fig. 10a - Switching Time Test Circuit

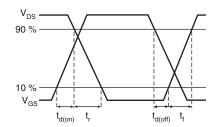


Fig. 10b - Switching Time Waveforms

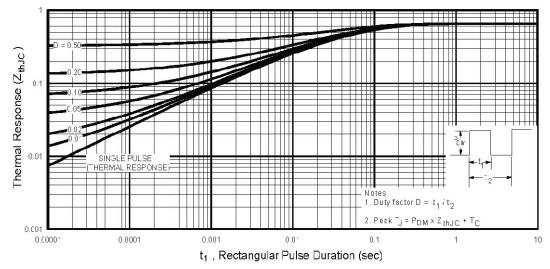


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

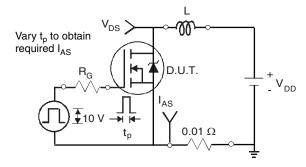


Fig. 12a - Unclamped Inductive Test Circuit

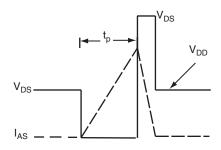


Fig. 12b - Unclamped Inductive Waveforms

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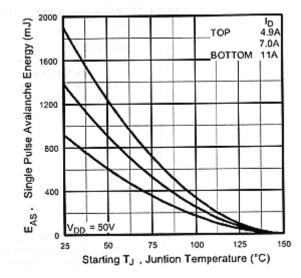


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

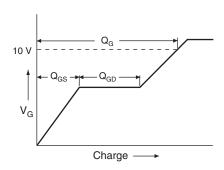


Fig. 13a - Basic Gate Charge Waveform

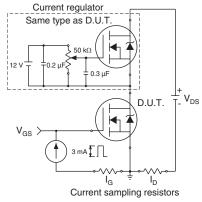
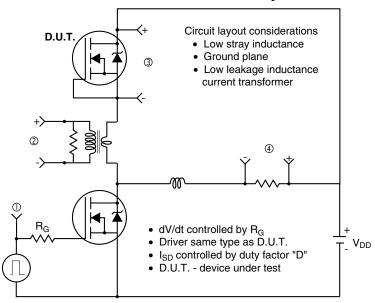
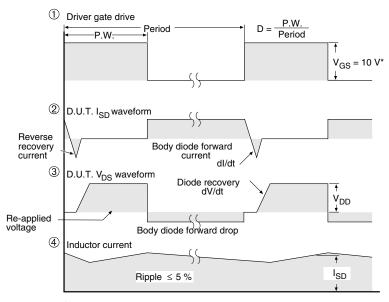


Fig. 13b - Gate Charge Test Circuit



## Peak Diode Recovery dV/dt Test Circuit





\* V<sub>GS</sub> = 5 V for logic level devices

Fig. 14 - For N-Channel

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